

STL33N60DM2

N-channel 600 V, 0.115 Ω typ., 21 A MDmesh[™] DM2 Power MOSFET in a PowerFLAT[™] 8x8 HV package

Datasheet - production data



Figure 1: Internal schematic diagram



Features

Order code	V _{DS} @ T _{Jmax}	R _{DS(on)} max	ID
STL33N60DM2	650 V	0.140 Ω	21 A

- Fast-recovery body diode
- Extremely low gate charge and input capacitance
- Low on-resistance
- 100% avalanche tested
- Extremely high dv/dt ruggedness
- Zener-protected

Applications

• Switching applications

Description

This high voltage N-channel Power MOSFET is part of the MDmeshTM DM2 fast recovery diode series. It offers very low recovery charge (Q_{rr}) and time (t_{rr}) combined with low $R_{DS(on)}$, rendering it suitable for the most demanding high efficiency converters and ideal for bridge topologies and ZVS phase-shift converters.

Table 1: Device summary

Order code	Marking	Package	Packaging
STL33N60DM2	33N60DM2	PowerFLAT™ 8x8 HV	Tape and reel

This is information on a product in full production.

Contents

Contents

1	Electric	al ratings	3
2	Electric	al characteristics	4
	2.1	Electrical characteristics (curves)	6
3	Test cir	cuits	8
4	Packag	e mechanical data	9
	4.1	PowerFLAT™ 8x8 HV package mechanical data	10
	4.2	PowerFLAT™ 8x8 HV packing information	12
5	Revisio	n history	14

57

1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{GS}	Gate-source voltage	± 25	V
I _D ⁽¹⁾	Drain current (continuous) at $T_c = 25 \ ^{\circ}C$	21	А
I _D ⁽¹⁾	Drain current (continuous) at T _c = 100 °C	15	А
I _{DM} ⁽¹⁾ , ⁽²⁾	Drain current (pulsed)	84	А
P _{TOT} ⁽¹⁾	Total dissipation at $T_C = 25 \text{ °C}$	150	W
I _{AR}	Avalanche current, repetitive or not-repetitive (pulse width limited by T_j max)	4.5	А
E _{AS}	Single pulse avalanche energy (starting $T_j = 25 \text{ °C}$, $I_D = I_{AR}$, $V_{DD} = 50 \text{ V}$)	570	mJ
dv/dt ⁽³⁾	Peak diode recovery voltage slope	50	V/ns
dv/dt ⁽⁴⁾	MOSFET dv/dt ruggedness	50	V/ns
T _{stg}	Storage temperature range	55 to 150	ŝ
Tj	Operating junction temperature range	- 55 to 150	°C

Notes:

 $^{(1)}\mbox{The}$ value is rated according to $R_{\mbox{th}j\mbox{-case}}$ and limited by package.

 $^{\rm (2)}{\rm Pulse}$ width limited by safe operating area.

 $^{(3)}I_{SD} \leq 21$ A, di/dt ≤ 900 A/µs, V_DS(peak) < V(BR)DSS, V_DD = 400 V.

⁽⁴⁾V_{DS} ≤ 480 V.

Table	3:	Thermal	data
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Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case max	0.83	°C/W
R _{thj-amb} ⁽¹⁾	Thermal resistance junction-ambient max	45	°C/W

Notes:

 $^{(1)}\!When$ mounted on FR-4 board of inch², 2oz Cu.



2 Electrical characteristics

(T_c = 25 °C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0$, $I_D = 1$ mA	600			V
	Zoro goto voltogo	$V_{GS} = 0, V_{DS} = 600 V$			1	μA
I _{DSS}	Zero gate voltage drain current	$V_{GS} = 0,$ $V_{DS} = 600 \text{ V}, \text{ T}_{C} = 125 ^{\circ}\text{C}^{(1)}$			100	μA
I _{GSS}	Gate-body leakage current	$V_{DS} = 0, V_{GS} = \pm 25 V$			±10	μA
V _{GS(th)}	Gate threshold voltage	$V_{DS}=V_{GS},\ I_{D}=250\ \mu A$	3	4	5	V
R _{DS(on)}	Static drain-source on- resistance	V_{GS} = 10 V, I _D = 10.5 A		0.115	0.140	Ω

Table 4: On /off states

Notes:

⁽¹⁾Defined by design, not subject to production test.

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		-	1870	-	pF
C _{oss}	Output capacitance	$V_{DS} = 100 V$, f = 1 MHz,	-	87	-	pF
C _{rss}	Reverse transfer capacitance	V _{GS} = 0	-	2	-	pF
C _{oss eq.} ⁽¹⁾	Equivalent output capacitance	$V_{DS} = 0 \text{ to } 480 \text{ V}, V_{GS} = 0$	-	157	-	pF
R_G	Intrinsic gate resistance	f = 1 MHz, I _D =0 A	-	4.5	-	Ω
Qg	Total gate charge	$V_{DD} = 480 \text{ V}, \text{ I}_{D} = 21 \text{ A}$	-	43	-	nC
Q _{gs}	Gate-source charge	V _{GS} = 10 V	-	9.8	-	nC
Q _{gd}	Gate-drain charge	(see Figure 15: "Gate charge test circuit")	-	21.4	-	nC

Table 5: Dynamic

Notes:

(1) Coss eq. is defined as a constant equivalent capacitance giving the same charging time as Coss when VDS increases from 0 to 80% VDSS.



Electrical characteristics

	Table 6: Switching times						
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
t _{d(on)}	Turn-on delay time	$V_{DD} = 300 \text{ V}, I_D = 10.5 \text{ A}$	-	17	-	ns	
tr	Rise time	R_{G} = 4.7 Ω , V_{GS} = 10 V	-	8	-	ns	
t _{d(off)}	Turn-off delay time	(see Figure 14: "Switching times test circuit for resistive	-	62	-	ns	
t _f	Fall time	load")	-	9	-	ns	

Table 7: Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD} ⁽¹⁾	Source-drain current		-		21	А
I _{SDM} ⁽¹⁾⁽²⁾	Source-drain current (pulsed)		-		84	А
V _{SD} ⁽³⁾	Forward on voltage	$I_{SD} = 21 \text{ A}, V_{GS} = 0$	-		1.6	V
t _{rr}	Reverse recovery time	$I_{SD} = 21 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$ $V_{DD} = 100 \text{ V}$ (see Figure 16: "Test	-	120		ns
Q _{rr}	Reverse recovery charge		-	0.53		μC
I _{RRM}	Reverse recovery current	circuit for inductive load switching and diode recovery times")		8.8		А
t _{rr}	Reverse recovery time	I _{SD} = 21 A, di/dt = 100 A/µs	-	316		ns
Qrr	Reverse recovery charge	V_{DD} = 100 V, T _j = 150 °C (see <i>Figure 16: " Test circuit for</i>	-	2.85		μC
I _{RRM}	Reverse recovery current	inductive load switching and diode recovery times")	-	18		А

Notes:

 $^{(1)}\mbox{The value is rated according to $R_{\mbox{thj-case}}$ and limited by package.}$

⁽²⁾Pulse width limited by safe operating area

 $^{(3)}\text{Pulsed:}$ pulse duration = 300 $\mu\text{s},$ duty cycle 1.5%

Table 8: Gate-source Zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)GSO}	Gate-source breakdown voltage	$I_{GS} = \pm 250 \ \mu A, I_D = 0 \ A$	±30	-	-	V

The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.









DocID026781 Rev 2



Electrical characteristics









3 Test circuits







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4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK[®] is an ST trademark.



Package mechanical data

4.1 PowerFLAT[™] 8x8 HV package mechanical data



DocID026781 Rev 2



STL33N60DM2

Package mechanical data

Dim	mm				
Dim.	Min.	Тур.	Max.		
А	0.75	0.85	0.95		
A1	0.00		0.05		
A3	0.10	0.20	0.30		
b	0.90	1.00	1.10		
D	7.90	8.00	8.10		
E	7.90	8.00	8.10		
D2	7.10	7.20	7.30		
E1	2.65	2.75	2.85		
E2	4.25	4.35	4.45		
е		2.00			
L	0.40	0.50	0.60		

Figure 21: PowerFLAT™ 8x8 HV footprint





All dimensions are in millimeters.



4.2 PowerFLAT[™] 8x8 HV packing information



Figure 23: PowerFLAT™ 8x8 HV package orientation in carrier tape





Figure 24: PowerFLAT[™] 8x8 HV reel





5 Revision history

Table 10: Document revision history

Date	Revision	Changes
08-Aug-2014	1	First release.
09-Mar-2016	2	Updated title and internal schematic in cover page. Document status promoted from preliminary data to production data. Modified: Table 2: "Absolute maximum ratings", Table 4: "On /off states", Table 5: "Dynamic", Table 6: "Switching times" and Table 7: "Source drain diode" Added: Section 4.1: "Electrical characteristics (curves)" Updated: Section 6.1: "PowerFLAT™ 8x8 HV package mechanical data" Minor text changes



STL33N60DM2

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